LNA4905L

GaAlAs Infrared Light Emitting Diode

For optical control systems

Features

- High-power output, high-efficiency: $P_0 = 15 \text{ mW} \text{ (min.)}$
- \bullet Fast response and high-speed modulation capability: f_{C} = 30 MHz (typ.)
- Transparent epoxy resin package

Absolute Maximum Ratings $T_a = 25^{\circ}C$

Parameter	Symbol Rating		Unit	
Power dissipation	P _D	190	mW	
Forward current	$I_{\rm F}$	I _F 100		
Pulse forward current *	I _{FP}	1	А	
Reverse voltage	V _R	3	V	
Operating ambient temperature	T _{opr}	T _{opr} -25 to +85		
Storage temperature	T _{stg}	-30 to +100	°C	

Note) *: f = 100 Hz, Duty cycle = 0.1%

Electrical-Optical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Radiant power	Po	$I_F = 50 \text{ mA}$	15			mW
Reverse current	I _R	$V_R = 3 V$			10	μΑ
Forward voltage	V _F	$I_F = 100 \text{ mA}$		1.7	2.1	V
Peak emission wavelength	λ_{P}	$I_F = 50 \text{ mA}$		880		nm
Spectral half band width	Δλ	$I_F = 50 \text{ mA}$		50		nm
Half-power angle	θ	The angle when the radiant power is halved.		15		0

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 measuring methods for diodes.

2. Cutoff frequency: 30 MHz

$$f_{\rm C}: 10 \times \log \frac{P_{\rm O} \operatorname{at} f = f_{\rm C}}{P_{\rm O} \operatorname{at} f = 1 \operatorname{MHz}} = -3$$

3. A light detection element uses a silicon diode have proofread a load with a standard device.

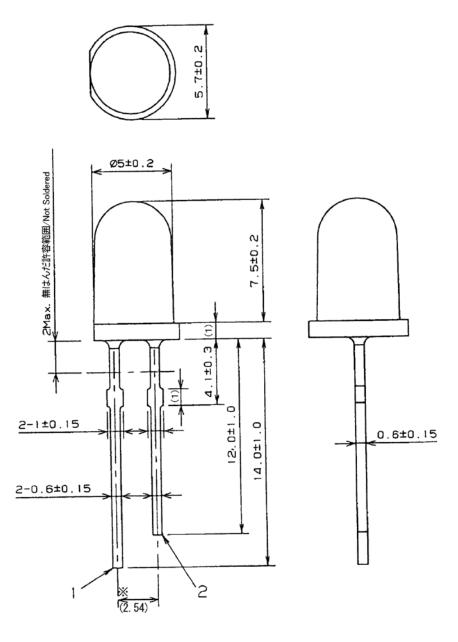
4. LED might radiate red light under large current drive.

LNA4905L

Panasonic

Package (Unit: mm)

LEXLTN2S0001



• Pin name

1: Anode 2: Cathode

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